

## Chif Ferrite Bead Arrays

## Features

1. Available in a wide range of impedance values.
2. Providing excellent EMI suppression characteristics for various types of noise.
3. 4 lines achieved with a single chip, very useful in high density circuit design.
4. Heat generation and crosstalk between adjacent circuits are at minimum.
5. Excellent solderability.
6. RoHS compliant with Directive 2002/95/EC of the European Parliament and of the Council of 27 January 2003 on the restriction of the use of certain hazardous substances in electrical and electronic equipment (RoHS Directive) and comply to a maximum concentration value of $0.1 \%$ by weight in homogeneous materials for lead ( Pb ), mercury, hexavalent chromium, polybrominated biphenyls (PBB) and polybrominated diphenyl ethers (PBDE) and of $0.01 \%$ weight in homogeneous materials for cadmium.

## Applications

1. Waveform correction in personal computers, electric equipment, communication equipment, OA equipment.
2. Provides radiated noise countermeasures in interfaces and harness connecting parts.
3. Prevents noise intrusion in video, LCD module, etc.
4. Parallel signal line.

## Ordering Information

$\frac{\text { WPB }}{(1)} \quad$| $(2)$ | $\frac{M}{(3)}$ | $-\frac{3216}{(4)}$ | $\frac{\square}{(5)}$ | - | $\frac{121}{(6)} \quad \frac{T}{(7)}$ |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- |

## (1) Series

WPB: For signal line
(2) Type

4: Array
(3) Material and Design

H: For general purpose
S: For high speed
M: For high impedance type
T, V: For Low speed
(4) Dimensions*

First two digits: length(mm)
Last two digits: width(mm)
(5) Thickness

A: 0.9 mm max
B: 0.7 mm max
C: 1.2 mm max
(6) Impedence (at 100 MHz )

First two digits are impedance values.
Last digit is the number of zeros following.
(7) Packaging

B: Bulk Package
T: Tape \& Reel ( $\Phi$ 178mm [ 7 inch ])
L: Tape \& Reel ( $\Phi$ 254mm [10 inch ])
*2012(mm) is equivalent to 0805 (inches).
$3216(\mathrm{~mm})$ is equivalent to 1206 (inches).

## Shape \& Dimensions

| Type |  | L | W | T | $\mathrm{C}_{1}$ | $\mathrm{C}_{2}$ | D | M |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| WPB-4D2010 | B | $\begin{gathered} 2.00 \pm 0.15 \\ {[.079 \pm .006]} \end{gathered}$ | $\begin{gathered} 1.00 \pm 0.15 \\ {[.063 \pm .008]} \end{gathered}$ | $\begin{gathered} 0.60 \pm 0.1 \\ {[.031 \pm .004]} \end{gathered}$ | $\begin{gathered} 0.25 \pm 0.15 \\ {[.020 \pm .006]} \end{gathered}$ | $\begin{gathered} 0.3 \mathrm{max} \\ {[.012 \mathrm{max}]} \end{gathered}$ | $\begin{gathered} 0.50 \pm 0.10 \\ {[.020 \pm .004]} \end{gathered}$ | $\begin{gathered} 0.2 \mathrm{max} \\ {[.008 \mathrm{max}]} \end{gathered}$ |
| WPB-4D3216 | A | $\begin{gathered} 3.20 \pm 0.2 \\ {[.126 \pm .008]} \end{gathered}$ | $\left[\begin{array}{c} 1.60 \pm 0.2 \\ {[.063 \pm .008]} \end{array}\right.$ | $\begin{gathered} 0.80 \pm 0.1 \\ {[.031 \pm .004]} \end{gathered}$ | $\left[\begin{array}{c} 0.40 \pm 0.15 \\ {[.016 \pm .006]} \end{array}\right.$ | $\left[\begin{array}{c} 0.30 \pm 0.10 \\ {[.012 \pm .004]} \end{array}\right.$ | $\begin{gathered} 0.80 \pm 0.1 \\ {[.031 \pm .004]} \end{gathered}$ | $\begin{gathered} 0.20 \pm 0.1 \\ {[.008 \pm .004]} \end{gathered}$ |
|  | B | $\left[\begin{array}{c} 3.20 \pm 0.2 \\ {[.126 \pm .008]} \end{array}\right.$ | $\left[\begin{array}{c} 1.60 \pm 0.2 \\ {[.063 \pm .008]} \end{array}\right.$ | $\begin{gathered} 0.60 \pm 0.1 \\ {[.024 \pm .004]} \end{gathered}$ | $\begin{gathered} 0.40 \pm 0.15 \\ {[.016 \pm .006]} \end{gathered}$ | $\begin{aligned} & 0.30 \pm 0.10 \\ & {[.012 \pm .004]} \end{aligned}$ | $\begin{gathered} 0.80 \pm 0.10 \\ {[.031 \pm .004]} \end{gathered}$ | $\begin{gathered} 0.20 \pm 0.1 \\ {[.008 \pm .004]} \end{gathered}$ |
|  | C | $\left[\begin{array}{c} 3.2 \pm 0.2 \\ {[.126 \pm .008]} \end{array}\right.$ | $\begin{gathered} 1.60 \pm 0.2 \\ {[.063 \pm .008]} \end{gathered}$ | $\begin{gathered} 1.10 \pm 0.1 \\ {[.043 \pm .004]} \end{gathered}$ | $\left[\begin{array}{c} 0.40 \pm 0.15 \\ {[.016 \pm .006]} \end{array}\right.$ | $\left[\begin{array}{c} 0.30 \pm 0.10 \\ {[.012 \pm .004]} \end{array}\right.$ | $\begin{aligned} & 0.80 \pm 0.10 \\ & {[.031 \pm .004]} \end{aligned}$ | $\begin{gathered} 0.20 \pm 0.1 \\ {[.008 \pm .004]} \end{gathered}$ |



## Chip Ferrite Bead Arrays

## Specifications

| Part No． | IZI at $100 \mathrm{MHz}(\Omega)$ |  | DCR <br> $(\Omega)$ max | Rated current （mA）max |
| :---: | :---: | :---: | :---: | :---: |
|  | typ | min |  |  |
| WPB－4M2010ロ－100ロ | 10 | 7.5 | 0.10 | 200 |
| WPB－4M2010ロ－400ロ | 40 | 30 | 0.15 | 200 |
| WPB－4M2010ロ－600ロ | 60 | 45 | 0.30 | 200 |
| WPB－4M2010ロ－800ロ | 80 | 60 | 0.30 | 200 |
| WPB－4M2010口－121口 | 120 | 90 | 0.40 | 150 |
| WPB－4M2010ロ－201ロ | 200 | 150 | 0.60 | 100 |
| WPB－4M2010ロ－301ם | 300 | 225 | 0.80 | 50 |
| WPB－4T2010ロ－100ロ | 10 | 7.5 | 0.10 | 200 |
| WPB－4T2010ロ－400ロ | 40 | 30 | 0.15 | 200 |
| WPB－4T2010ロ－600ロ | 60 | 45 | 0.30 | 200 |
| WPB－4T2010ロ－800ロ | 80 | 60 | 0.30 | 200 |
| WPB－4T2010ロ－121ロ | 120 | 90 | 0.40 | 150 |
| WPB－4T2010ロ－201ロ | 200 | 150 | 0.60 | 100 |
| WPB－4T2010ロ－301ם | 300 | 225 | 0.80 | 50 |
| WPB－4S2010ロ－100ロ | 10 | 7.5 | 0.20 | 200 |
| WPB－4S2010ロ－300ם | 30 | 23 | 0.30 | 200 |
| WPB－4S2010ロ－600ロ | 60 | 45 | 0.40 | 150 |
| WPB－4S2010ロ－101ם | 100 | 75 | 0.50 | 150 |
| WPB－4H3216ロ－300ם | 30 | 22 | 0.10 | 200 |
| WPB－4M3216口－600ロ | 60 | 45 | 0.12 | 200 |
| WPB－4M32160ロ－800ロ | 80 | 60 | 0.15 | 150 |
| WPB－4M32160ロ－121ロ | 120 | 90 | 0.20 | 100 |
| WPB－4M3216口－201ם | 200 | 150 | 0.30 | 100 |
| WPB－4M3216口－241ロ | 240 | 180 | 0.40 | 100 |
| WPB－4M3216ロ－301ロ | 300 | 225 | 0.45 | 100 |
| WPB－4M3216口－471ם | 470 | 353 | 0.45 | 100 |
| WPB－4M3216口－601ם | 600 | 450 | 0.50 | 100 |
| WPB－4M3216口－102口 | 1000 | 750 | 0.80 | 100 |
| WPB－4T3216ロ－600ロ | 600 | 450 | 0.12 | 200 |
| WPB－4T3216ロ－121ם | 120 | 90 | 0.20 | 200 |
| WPB－4T3216ロ－201ロ | 200 | 150 | 0.30 | 150 |
| WPB－4T3216ロ－241ם | 240 | 180 | 0.40 | 150 |
| WPB－4T3216ロ－301ロ | 300 | 225 | 0.45 | 150 |
| WPB－4T3216ロ－601ם | 600 | 450 | 0.50 | 100 |
| WPB－4T3216ロ－102ם | 1000 | 750 | 0.80 | 50 |
| WPB－4S2316ロ－500ロ | 50 | 37 | 0.20 | 200 |
| WPB－4S3216ロ－800ロ | 80 | 60 | 0.25 | 200 |
| WPB－4S3216口－121ם | 120 | 90 | 0.25 | 200 |
| WPB－4S3216ロ－201ם | 200 | 150 | 0.30 | 200 |
| WPB－4S3216ロ－241ם | 240 | 180 | 0.35 | 200 |
| WPB－4S3216ロ－301ロ | 300 | 225 | 0.40 | 200 |
| WPB－4V3216ロ－400ם | 40 | 30 | 0.15 | 200 |
| WPB－4V3216ロ－600ロ | 60 | 45 | 0.20 | 200 |
| WPB－4V3216ロ－800ロ | 80 | 60 | 0.20 | 200 |
| WPB－4V3216ロ－121口 | 120 | 90 | 0.30 | 150 |
| WPB－4V3216ロ－201ロ | 200 | 150 | 0.40 | 100 |
| WPB－4V3216ロ－301ロ | 300 | 225 | 0.50 | 100 |

## Chip Ferrite Bead Arrays

## Electrical Characteristics




WPB-4T3216A-301





WPB-4T3216A-601



WPB-4T3216A-201


WPB-4T3216A-102




WPB-4M2010B-201


WPB-4M2010B-600


WPB-4M2010B-301


## Chif Ferrive Bead Arrays

## Reliability and Test Conditions

| ITEM |  | REQUIREMENTS |  |  | TEST CONDITION |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | 321 | 2012 |  |  |
| Operating temp.range |  | $-55^{\circ} \mathrm{C} \sim+125^{\circ} \mathrm{C}$ |  |  | - |
| Storage temp. \& humidity range |  | $40^{\circ} \mathrm{C}$ max. , 70\% RH max. |  |  | at packing condition |
| Resistance to solder heat |  | 1. No damage such as cracks should be caused in chip element. <br> 2. More than $75 \%$ of the terminal electrode shall be covered with new solder. <br> 3. Impedance change: $\pm 30 \%$ |  |  | Preheat temperature: 100 to $150^{\circ} \mathrm{C}$ <br> Preheat time: 1 min <br> Solder temperature: $260 \pm 10^{\circ} \mathrm{C}$ <br> Dipping time: $10 \pm 0.5 \mathrm{sec}$. |
| Solderability |  | 1. More than $90 \%$ of the terminal electrode shall be covered with new solder. <br> 2. Inductance change : $\pm$ within $5 \%$ <br> 3. Impedance change: $\pm 30 \%$ |  |  | Preheat temperature: 100 to $150^{\circ} \mathrm{C}$ Preheat time: 1 min Solder temperature: $230 \pm 10^{\circ} \mathrm{C}$ Dipping time: $3 \pm 1 \mathrm{sec}$. |
| Reflow soldering |  | 1. More covered | of the termina older. <br> $S \geq$ | ode shall be | Preheat temperature: $150^{\circ} \mathrm{C}$ Preheat time: 1min <br> Solder temperature: $230 \pm 10^{\circ} \mathrm{C}$ <br> Dipping time: $3 \pm 1 \mathrm{sec}$. |
| Tensile strength (Terminal strength) |  | 1. No mechanical damage. |  |  |  |
|  | W | 1.2(1.0) | 0.6 | "T"max. 0.7 mm |  |
| Adhension of Terminal electrode (Flexure strength) |  | 1. No mechanical damage $\quad \begin{aligned} & \\ & \\ & \\ & \text { Unit : mm (a,b,c), Kgf(W) }\end{aligned}$ |  |  |  |
|  | a | 0.8 | 0.5 | - |  |
|  | b | 0.8 | 0.5 | - |  |
|  | C | 3.0 | 2.0 | - |  |
|  | d | 0.4 | 0.25 | - |  |
|  | W | 5.0 | 2.0 | - |  |
| Body strength (Bending strength) |  | 1. The body shall not be damaged by forces applied (see illustration.) |  |  | $\downarrow w$ |
|  |  | Unit : mm (d), Kgf(W) |  |  |  |
|  | d | 2.0 | 1.3 | - | $\square \xrightarrow{\text { d }} \longrightarrow \square$ |
|  | W | 3.0 | 2.0 | - |  |

## Chif Ferrite Bead Arrays

## Reliability and Test Conditions

| ITEM | REQUIREMENTS | TEST CONDITION |
| :---: | :---: | :---: |
|  | 32162012 |  |
| Drop | 1. No mechanical damage <br> 2. Impedance change: $\pm$ within $30 \%$ | Drop 10 times on a concrete Floor from a height of 91 cm |
| Vibration | 1. No mechanical damage <br> 2. Impedance change: $\pm$ within $30 \%$ | Frequency: 10~55~10Hz Amplitude: 1.52 mm Direction and time: $\mathrm{X}, \mathrm{Y}, \mathrm{Z}$ directions for 2 hours |
| Thermal shock (Temperature cycle) | 1. No mechanical damage <br> 2. Impedance change: $\pm$ within $30 \%$ | Step1. $-40 \pm 3^{\circ} \mathrm{C} 30 \pm 3 \mathrm{~min}$. Step2. $85 \pm 3^{\circ} \mathrm{C} 30 \pm 3 \mathrm{~min}$. Number of cycle: 100 times |
| Heat load resistance | 1. No mechanical damage <br> 2. Impedance change: $\pm$ within $30 \%$ | Temperature: $85 \pm 2^{\circ} \mathrm{C}$ Applied current: rated current Time: 1,000 hours Measured at ambient temperature after placing for 24 hours |
| Low temp. resistance | 1. No mechanical damage <br> 2. Impedance change: $\pm$ within $30 \%$ | Temperature: $-40 \pm 5^{\circ} \mathrm{C}$ <br> Time: 1,000 hours Measured at ambient temperature after placing for 24 hours |
| Humidity resistance | 1. No mechanical damage <br> 2. Impedance change: $\pm$ within $30 \%$ | Temperature: $40 \pm 2^{\circ} \mathrm{C}$ <br> Humidity: 90~95\% RH <br> Applied current: rated current <br> Time: 500 hours <br> Measured at ambient temperature after placing for 24 hours |
| Humidity load resistance | 1. No mechanical damage <br> 2. Impedance change: $\pm$ within $30 \%$ | Temperature: $40 \pm 2^{\circ} \mathrm{C}$ <br> Humidity: 90~95\% RH <br> Applied current: rated current <br> Time: 500 hours <br> Measured at ambient temperature <br> after placing for 24 hours |
| Cross | 1. Cross talk: Max -30 dB <br> 2. Cross talk= $20 \log (\mathrm{Vx} / \mathrm{Vin})$ | Drop voltage: 5 V <br> Pulse Width: 100ns <br> Pulse duration: 16.6 ms <br> Test diagram: Fig. 1 |



Drop voltage (a~b): Vin (5Vrms)
Output voltage(1,2,3,~4): Vx

Fig. 1 Cross talk test diagram

## Land Pattern Design



## Labeling

Label

1) Part name.
2) Lot No.
3) Quantity.

Standard quantity for packing

| Packing Type(EIA) | Tape \& reel |  |  |  |
| :---: | :---: | :---: | :---: | :---: |
|  | Reel | Inner box | Carton box | Vinyl or Cassette |
| 3216 | 3,000 | 30,000 | 120,000 | As requested |
|  | 7,000 | 70,000 | 280,000 |  |

*Packing method can be changed upon request.

## Tape Dimensions

## Embossing 8mm


unit: mm

| Type | $\mathrm{A} \pm 0.1$ | $\mathrm{~B} \pm 0.1$ | $\mathrm{P} \pm 0.1$ | $\mathrm{~K}_{0} \pm 0.1$ | T (max.) |
| :---: | :---: | :---: | :---: | :---: | :---: |
| 3216 | 1.90 | 3.60 | 4.0 | 1.00 | 0.3 |
|  | 1.90 | 3.60 | 4.0 | 1.35 | 0.3 |

## Leader and Blank Portion



Drawing direction

The pitch holes shift within $\pm 0.3 \mathrm{~mm}$ for cumulative 10 pitches.

## Reel Dimensions



## Top Cover Tape Strength



The force for tearing off top cover tape is 20 to 70 grams in the arrow direction.

## Soldering Profile



## Precaution for Storage

Electrical characteristics of product will not change when stored under typical environmental conditions. However, it is possible that the solderability of terminal electrodes and the characteristics of the tape packaging can change during storage. For this reason, the following storage guidelines should be followed.

1. Storage Environment: The tape packaging material is designed to withstand long-term storage but they will degrade more rapidly in the presence of high temperature or high humidity. Therefore, product shall be stored in an ambient temperature of less than $40^{\circ} \mathrm{C}$ with a relative humidity of less than $70 \%$. The products should be used within 6 months of receipt. To achieve best solderability, product should be used as soon as possible after unpacking. Leftover product must be stored in dry condition with desiccant.
2. Corrosive gases: Since sulfur and chlorine may degrade the solderability of the terminal electrodes, it is important to store the product in an environment free of such gases.
3. Temperature fluctuations: Dew condensation may occur when the product is taken out of storage due to variation of temperature. It is important to maintain a temperature-controlled environment.

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